







SN74HC4852-Q1 SCLS705B - DECEMBER 2006 - REVISED JUNE 2024

SN74HC4852-Q1 Automotive Dual 4-to-1 Channel Analog Multiplexer/Demultiplexer With Injection-Current Effect Control

1 Features

Texas

INSTRUMENTS

- Qualified for automotive applications
- Injection current cross-coupling <1mV/mA (see Figure 8-1)
- Low crosstalk between switches
- Pin compatible with SN74HC4052, SN74LV4052A, and CD4052B
- 2V to 5.5V V _{CC} operation
- Latch-up performance exceeds 100mA per JESD 78, Class II

2 Applications

- Analog signal switching or multiplexing:
 - Signal gating, modulator, squelch control, demodulator, chopper, commutating switch
- Digital signal switching and multiplexing
 - Audio and video signal routing
- Transmission-gate logic implementation
- Analog-to-digital and digital-to-analog conversion
- Digital control of frequency, impedance, phase, and analog-signal gain
- Motor speed control
- Battery chargers ٠
- **DC-DC** converter

3 Description

dual 4-to-1 CMOS multiplexer/ This analog demultiplexer is pin compatible with the 4052 function and also features injection-current effect control. This feature has excellent value in automotive applications where voltages in excess of normal supply voltages are common.

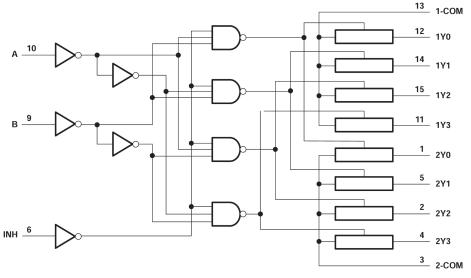
The injection-current effect control allows signals at disabled analog input channels to exceed the supply voltage without affecting the signal of the enabled analog channel. This eliminates the need for external diode/resistor networks typically used to keep the analog channel signals within the supply voltage range.

Package Information

PART NUMBER	PACKAGE ⁽¹⁾	PACKAGE SIZE ⁽²⁾		
SN74HC4852-Q1	PW (TSSOP, 16)	5mm × 6.4mm		

For more information, see Section 11. (1)

The package size (length × width) is a nominal value and (2)includes pins, where applicable.



Functional Diagram



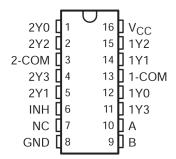


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4 Pin Configuration and Functions



NC - No internal connection

Figure 4-1. PW Package, 16-Pin TSSOP (Top View)

Table 4-1. Function Table

	INPUTS	ON CHANNEL	
INH	В	Α	ON CHANNEL
L	L	L	1Y0, 2Y0
L	L	Н	1Y1, 2Y1
L	Н	L	1Y2, 2Y2
L	Н	Н	1Y3, 2Y3
Н	Х	Х	None



5 Specifications

5.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)⁽¹⁾ (2)

		MIN	MAX	UNIT	
V _{CC}	Supply voltage	-0.5	6	V	
$\rm V_{SEL}$ or $\rm V_{EN}$	Logic control input pin voltage (EN, A0, A1, A2)	-0.5	V _{CC} +0.5V	V	
V_{S} or V_{D}	Source or drain voltage (Sx, D)	-0.5	V _{CC} +0.5V	V	
I _{IK}	Input clamp current ($V_I < 0$ or $V_I > V_{CC}$)	-20	20	mA	
I _{IOK}	I/O diode current ($V_{IO} < 0$ or $V_{IO} > V_{CC}$)	-20	20	mA	
Ι _Τ	Switch through current (V_{IO} = 0 to V_{CC})	-25	25	mA	
I _{GND}	Continuous current through V _{CC} or GND	-50	50	mA	
T _{stg}	Storage temperature	-65	150	°C	
TJ	Junction temperature		150		

(1) Operation outside the Absolute Maximum Ratings may cause permanent device damage. Absolute maximum ratings do not imply functional operation of the device at these or any other conditions beyond those listed under Recommended Operating Conditions. If briefly operating outside the Recommended Operating Conditions but within the Absolute Maximum Ratings, the device may not sustain damage, but it may not be fully functional. Operating the device in this manner may affect device reliability, functionality, performance, and shorten the device lifetime.

(2) The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

5.2 ESD Ratings

				VALUE	UNIT	
V	Electrostatic discharge	Human body model (HBM), per AEC Q100-002 ⁽¹⁾	All pins	±2000	V	
V _(ESD)		Charged device model (CDM), per AEC Q100-011	All pins	±750	v	

(1) AEC Q100-002 indicates that HBM stressing shall be in accordance with the ANSI/ESDA/JEDEC JS-001 specification.

5.3 Thermal Information: SN74HC485x-Q1

		SN74HC485x-Q1	
	THERMAL METRIC ⁽¹⁾	PW (TSSOP)	UNIT
		PINS	
R _{0JA}	Junction-to-ambient thermal resistance	139.6	°C/W

(1) For more information about traditional and new thermal metrics, see the Semiconductor and IC Package Thermal Metrics application report.



5.4 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

			MIN NOM	MAX	UNIT	
V _{CC}	Supply voltage		2	5.5	V	
		2V	1.5			
		2.5V	2.1			
V _{IH}	Input logic high	3.3V	2.3		V	
		4.5V	3.15			
		5.5V	4.2			
		2V	0	0.5		
	Input logic low	2.5V	0	0.7	v	
V _{IL}		3.3V	0	0.8		
		4.5V	0	0.95		
		5.5V	0	1.05		
$V_{\text{SEL}} \text{or} V_{\text{EN}}$	Logic control input pin voltage (EN, A0, A1, A2)		0	V _{CC}	V	
$V_{S} \text{or} V_{D}$	Signal path input/output voltage (source or drain pin) (Sx, D)		0	V _{CC}	V	
		V _{CC} = 2V		1000		
		V _{CC} = 3V		800	ns	
Δt/Δv	Input transition rise or fall time	V _{CC} = 3.3V		700		
		V _{CC} = 4.5V		500		
		V _{CC} = 5.5V		400		
T _A	Ambient temperature		-40	125	°C	



5.5 Electrical Characteristics

At specified V_{CC} $\pm 10\%$

Typical values measured at nominal V_{CC} .

				Operating free-air temperature (T _A)							
PARAMETER		TEST CONDITIONS	Vcc	25°C		-40°	°C to 85°C	–40°C	to 125°	C	UNIT
				MIN TYP	MAX	MIN	TYP MAX	MIN	ТҮР	MAX	
R _{ON}	On-state switch	$V_{S} = 0V$ to V_{CC} $I_{SD} = 0.5mA$	2V 3V	500 215	650 280		670 320			700 360	Ω
	resistance		3.3V 4.5V	210 160	270 210		305 240			345 270	
	On-state		2V	4	210		240			270	
•	switch resistance	$V_{\rm S} = V_{\rm CC} / 2$	3V	2	14		16			18	
Δ _{RON}	matching between inputs	I _{SD} = 0.5mA	3.3V 4.5V	2	14 10		16 14			18 18	Ω
I	Control input current	V _I = V _{CC} or GND	5V		±0.1		±0.1			±1	μA
	Off-state switch leakage current (any one channel)	Switch Off $V_{INH}=V_{IH}$ $V_D = V_{CC} / GND$ $V_S = GND / V_{CC}$			±0.1		±0.5			±1	μΑ
I _{S(OFF)}	Off-state switch leakage current (common channel)		5V		±0.2		±2			±4	μA
I _{S(ON)}	Channel on- state leakage current	Switch Off $V_{INH}=V_{IL}$ $V_D = V_{CC} / GND$ $V_S = GND / V_{CC}$	5V		±0.1		±0.5			±1	μΑ
I _{DD}	V _{CC} supply current	Logic inputs = 0V or V_{CC}	5V		2		5			10	μA
C _{IC}	Control input capacitance	A, B, C, INH		3.5	10		10			10	pF
C _{IS}	Common terminal capacitance	Switch off		22	40		40			40	pF
C _{OS}	Switch terminal capacitance	Switch off		6.7	15		15			15	pF
C _{PD}	Power Dissipation Capacitance	No Load $t_r = t_f = 1ns$ f = 1MHz	3.3V 5V	32 37							pF



5.6 Timing Characteristics

At specified \bar{V}_{CC} ±10% Typical values measured at nominal $V_{CC}.$

					(Operati	ng free	-air temperatu	ire (T _A)		
PARAMETER		TEST CONDITIONS	Vcc		25°C		-40 °	°C to 85°C	-40°	C to 125°C	UNIT
				MIN	TYP	MAX	MIN	TYP MAX	MIN	TYP MAX	1
SWITCH	HING CHARACTERIST	ICS ⁽¹⁾									
			2V	7	19.5	33	6	34	6	35	
+	Propagation delay	C _L = 50pF	3V	3.6	12	17.5	2.5	19	2.5	20.5	
t _{PD}		Sx to D, D to Sx	3.3V	3.9	11	15.5	2.5	17	2.5	18.5	ns
			5V	2.3	8.6	13	2.1	13.8	2	15.2	1
	Transition-time between inputs		2V	25	44	94	25	103	25	103	
			3V	20	30	63		67		67	1
t _{TRAN}			3.3V	18	23	51		54		54	ns
			5V	15	18	43	15	46	15	46	1
			2V	15	39	64	13.8	75	12.5	75	
	Turnon-time from	$R_{I} = 10k\Omega, C_{I} = 50pF$	3V	7.9	30	45	6.2	50	5.5	55	
t _{ON(EN)}	enable	EN to D, EN to Sx	3.3V	7	26.5	42.5	6.4	47.5	5.4	52.5	ns
			5V	4	24	40	4.3	45	3.4	50	1
			2V	26	48.4	100	25	105	25	115	
	Turnoff time from		3V	15	21	90	14	100	14	110	
t _{OFF(EN)}	enable		3.3V	12	15	85	11	95	11	105	ns
			5V	24.5	41.4	80	24.2	90	24	100	1

 $t_{PLH}/t_{PHL} = t_{PD}$ propagation delay time, $t_{PZH}/t_{PZL} = t_{ON(EN)}$ enable delay time, $t_{PHZ}/t_{PLZ} = t_{OFF(EN)}$ disable delay time, t_{PLH}/t_{PHL} Channel (1) select = t_{TRAN}

5.7 Injection Current Coupling

At specified V_{CC} $\pm 10\%$

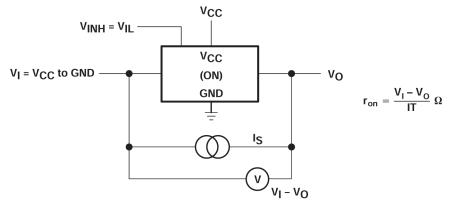
Typical values measured at nominal V_{CC} and T_A = 25°C.

PARAMETER		V _{cc}	TEST CONDITIONS		-40°C to 12	5°C	UNIT
	FARAMETER		1231 00	NUTIONS	MIN T	P MAX	UNIT
INJECTION	CURRENT COUPLING						
		3.3V		I _{INJ} ≤1mA	0.	05 1	
	Maximum shift of output voltage of enabled analog input ⁽¹⁾	5V	R _S ≤ 3.9kΩ	$I_{INJ} \ge IIIIA$	().1 1	
		3.3V	0	I _{INJ} ≤ 10mA	0.3	45 5	
A)/		5V			0.0	67 5	mV
ΔV _{OUT}		3.3V	$R_{S} \le 20 k\Omega$ $I_{INJ} \le 1 mA$ $I_{INJ} \le 10 mA$	1 1 1	0.	05 2	IIIV
		5V		$I_{INJ} \ge IIIIA$	0.	11 2	
		3.3V		$l_{m} \leq 10 m \Lambda$	0.	05 20	
		5V		$\eta_{NJ} \ge 10 \text{mA}$	0.0	24 20	

(1) I_{INJ} = total current injected into all disabled channels



6 Parameter Measurement Information





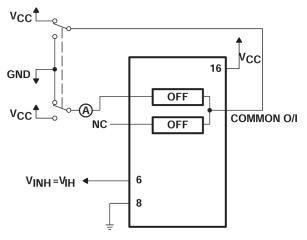


Figure 6-2. Maximum Off-Channel Leakage Current, Any One Channel, Test Setup

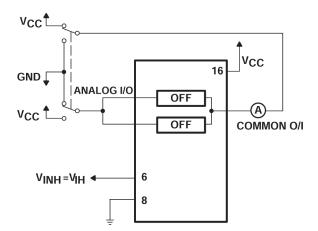
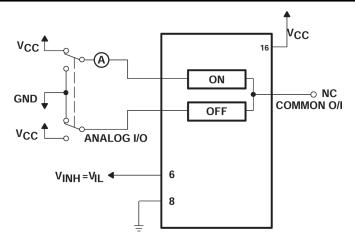
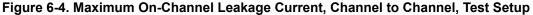
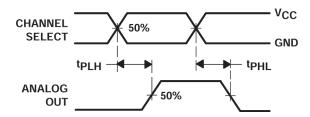


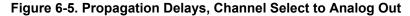
Figure 6-3. Maximum Off-Channel Leakage Current, Common Channel, Test Setup

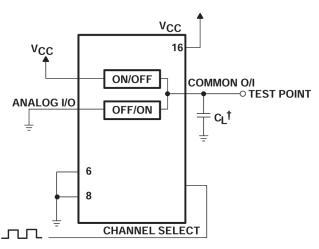














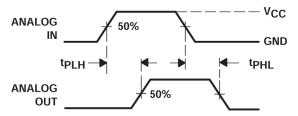


Figure 6-7. Propagation Delays, Analog in to Analog Out

t

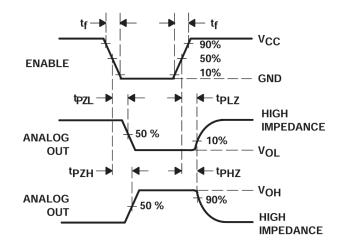
[†] Includes all probe and jig capacitance



t

ANALOG 16 COMMON O/I I/O ON I/O TEST POINT I/O CL^{\dagger}

Figure 6-8. Propagation Delay, Analog in to Analog Out, Test Setup





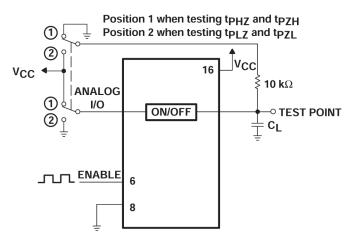


Figure 6-10. Propagation Delay, Enable to Analog Out, Test Setup

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[†] Includes all probe and jig capacitance



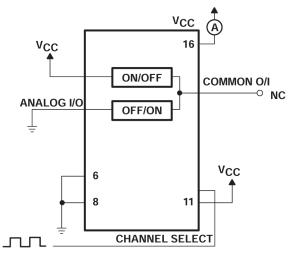
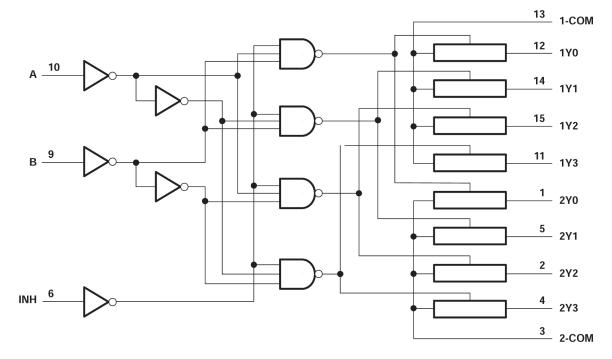


Figure 6-11. Power-Dissipation Capacitance, Test Setup



7 Detailed Description

7.1 Functional Block Diagram



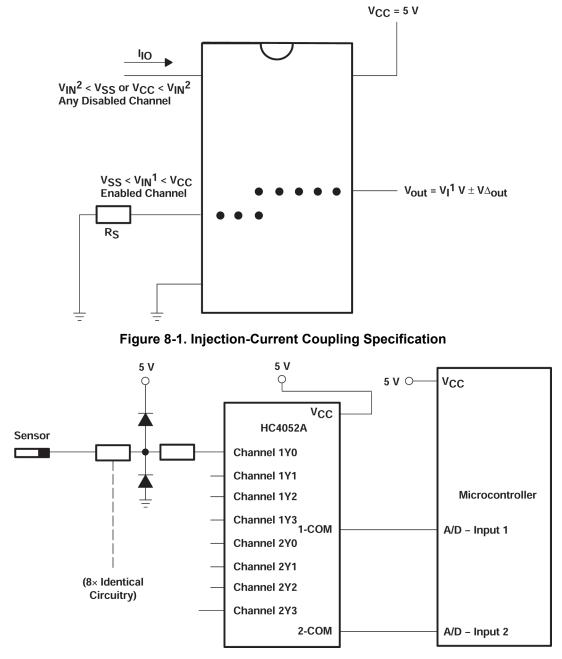


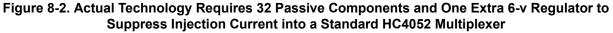
8 Application and Implementation

Note

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes, as well as validating and testing their design implementation to confirm system functionality.

8.1 Application Information







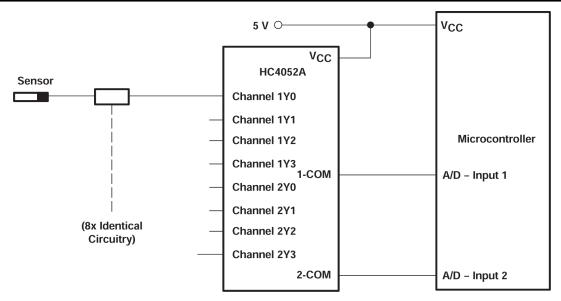


Figure 8-3. Solution by Applying the HC4852 Multiplexer

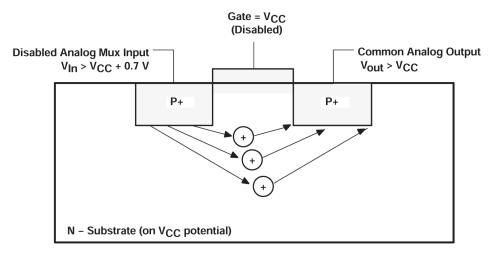


Figure 8-4. Diagram of Bipolar Coupling Mechanism (Appears If V_{In} Exceeds V_{CC}, Driving Injection Current into the Substrate)



9 Device and Documentation Support

9.1 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. Click on *Notifications* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

9.2 Support Resources

TI E2E[™] support forums are an engineer's go-to source for fast, verified answers and design help — straight from the experts. Search existing answers or ask your own question to get the quick design help you need.

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9.4 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

9.5 Glossary

TI Glossary This glossary lists and explains terms, acronyms, and definitions.

10 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

С	hanges from Revision A (December 2006) to Revision B (June 2024)	Page
•	Changed VCC ABS Max from 7V to 6V	3
	Changed RθJA	
•	Recommended supply changed from 6V to 5.5V and all test conditions using 6V were removed	4
•	Changed tpd, ttran, tON, tOFF parameters	<mark>6</mark>

11 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.



PACKAGING INFORMATION

Orderable part number	Status	Material type	Package Pins	Package qty Carrier	RoHS	Lead finish/	MSL rating/	Op temp (°C)	Part marking
	(1)	(2)			(3)	Ball material	Peak reflow		(6)
						(4)	(5)		
SN74HC4852QDRQ1	NRND	Production	SOIC (D) 16	2500 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	HC4852Q
SN74HC4852QDRQ1.A	NRND	Production	SOIC (D) 16	2500 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	HC4852Q
SN74HC4852QPWRQ1	Active	Production	TSSOP (PW) 16	2000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	HC4852Q
SN74HC4852QPWRQ1.A	Active	Production	TSSOP (PW) 16	2000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	HC4852Q

⁽¹⁾ **Status:** For more details on status, see our product life cycle.

⁽²⁾ Material type: When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

⁽³⁾ RoHS values: Yes, No, RoHS Exempt. See the TI RoHS Statement for additional information and value definition.

⁽⁴⁾ Lead finish/Ball material: Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

⁽⁵⁾ MSL rating/Peak reflow: The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

⁽⁶⁾ Part marking: There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

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OTHER QUALIFIED VERSIONS OF SN74HC4852-Q1 :



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23-May-2025

• Catalog : SN74HC4852

NOTE: Qualified Version Definitions:

• Catalog - TI's standard catalog product



Texas

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TAPE AND REEL INFORMATION





QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal												
Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
SN74HC4852QPWRQ1	TSSOP	PW	16	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1



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PACKAGE MATERIALS INFORMATION

24-Jul-2025



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
SN74HC4852QPWRQ1	TSSOP	PW	16	2000	353.0	353.0	32.0

D (R-PDSO-G16)

PLASTIC SMALL OUTLINE



NOTES: A. All linear dimensions are in inches (millimeters).

- B. This drawing is subject to change without notice.
- Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.006 (0,15) each side.
- Body width does not include interlead flash. Interlead flash shall not exceed 0.017 (0,43) each side.
- E. Reference JEDEC MS-012 variation AC.



PW0016A



PACKAGE OUTLINE

TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M. 2. This drawing is subject to change without notice. 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
- 5. Reference JEDEC registration MO-153.

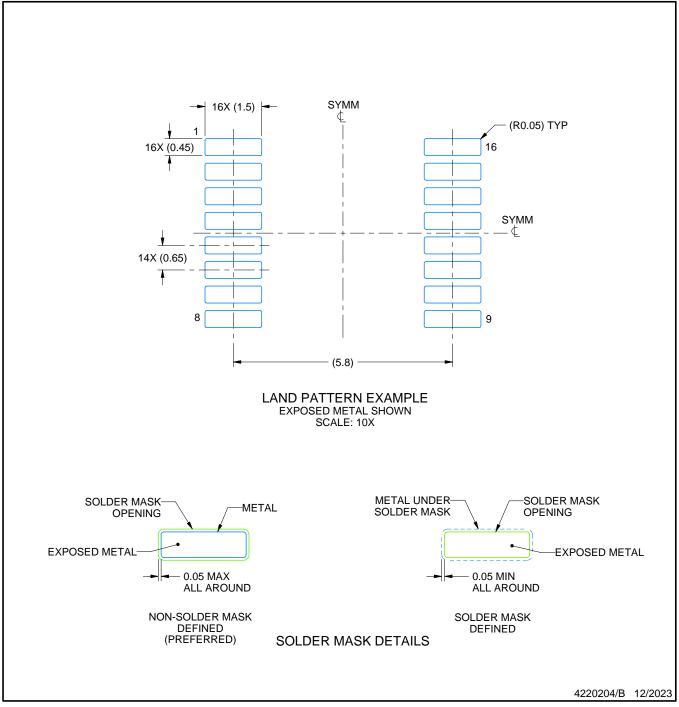


PW0016A

EXAMPLE BOARD LAYOUT

TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



PW0016A

EXAMPLE STENCIL DESIGN

TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE





^{8.} Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.

^{9.} Board assembly site may have different recommendations for stencil design.

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